SCES435B-APRIL 2003-REVISED SEPTEMBER 2004

#### **FEATURES**

- Member of the Texas Instruments Widebus™
  Family
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

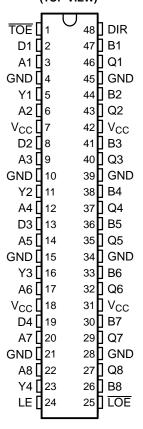
#### DESCRIPTION/ORDERING INFORMATION

This device contains four independent noninverting buffers and an 8-bit noninverting bus transceiver and D-type latch, designed for 1.65-V to 3.6-V  $V_{\rm CC}$  operation.

The SN74ALVCH16973 is particularly suitable for demultiplexing an address/data bus into a dedicated address bus and dedicated data bus. The device is used where there is asynchronous bidirectional communication between the A and B data bus, and the address signals are latched and buffered on the Q bus. The control-function implementation minimizes external timing requirements.

This device can be used as one 4-bit buffer, one 8-bit transceiver, or one 8-bit latch. It allows data transmission from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The transceiver output-enable (TOE) input can be used to disable the transceivers so that the A and B buses effectively are isolated.

# DGG, DGV, OR DL PACKAGE (TOP VIEW)



#### **ORDERING INFORMATION**

T <sub>A</sub>	PACKAGE <sup>(1)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SSOP - DL	Tube	SN74ALVCH16973DL	ALVCH16973
-40°C to 85°C	330P - DL	Tape and reel	SN74ALVCH16973DLR	ALVON10973
	TSSOP - DGG	Tape and reel	SN74ALVCH16973DGGR	ALVCH16973
	TVSOP - DGV	Tape and reel	SN74ALVCH16973DGVR	VH973

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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### **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

When the latch-enable (LE) input is high, the Q outputs follow the data (A) inputs. When LE is taken low, the Q outputs are latched at the levels set up at the A inputs. The latch output-enable (LOE) input can be used to place the nine Q outputs in either a normal logic state (high or low logic level) or the high-impedance state. In the high-impedance state, the Q outputs neither drive nor load the bus lines significantly. LOE does not affect internal operations of the latch. Old data can be retained or new data can be entered while the Q outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{\text{LOE}}$  and  $\overline{\text{TOE}}$  should be tied to  $V_{CC}$  through pullup resistors; the minimum values of the resistors are determined by the current-sinking capability of the drivers.

The four independent noninverting buffers perform the Boolean function Y = D and are independent of the state of DIR,  $\overline{TOE}$ , LE, and  $\overline{LOE}$ .

The A and B I/Os and D inputs have bus-hold circuitry. Active bus-hold circuitry holds unused or undriven data inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

#### **FUNCTION TABLES**

INP	UTS	OPERATION
TOE	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
Н	Х	A bus and B bus isolation

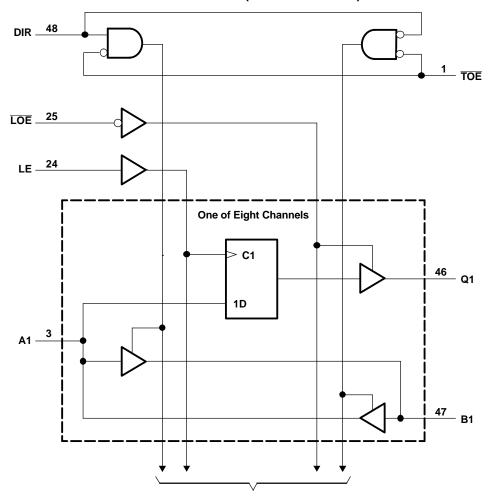
	OUTPUT		
LOE	LE	Α	Q
L	Н	Н	Н
L	Н	L	L
L	L	X	$Q_0$
Н	X	X	Z

INPUT D	OUTPUT Y
L	L
Н	Н

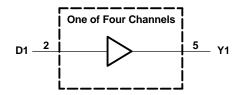


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### **LOGIC DIAGRAM (POSITIVE LOGIC)**



**To Seven Other Channels** 



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### ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
.,	lanut voltage range	Except I/O and D input ports (2)	-0.5	4.6	V
V <sub>I</sub>	Input voltage range	I/O and D input ports (2)(3)	-0.5 V <sub>CC</sub> + 0.5		V
Vo	Output voltage range <sup>(2)(3)</sup>	·	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through each V <sub>CC</sub> or GN	ID		±100	mA
		DGG package		70	
$\theta_{JA}$	Package thermal impedance (4)	DGV package		58	°C/W
		DL package		63	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### **RECOMMENDED OPERATING CONDITIONS<sup>(1)</sup>**

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		1.65	3.6	V	
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7		V	
		V <sub>CC</sub> = 3 V to 3.6 V	2			
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		
V <sub>IL</sub> Lo	Low-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	V	
		V <sub>CC</sub> = 3 V to 3.6 V		0.8		
VI	Input voltage		0	$V_{CC}$	V	
Vo	Output voltage		0	$V_{CC}$	V	
		V <sub>CC</sub> = 1.65 V		-4		
	High-level output current	V <sub>CC</sub> = 2.3 V		-12	^	
I <sub>OH</sub>		V <sub>CC</sub> = 2.7 V		-12	mA	
		V <sub>CC</sub> = 3 V		-24		
		V <sub>CC</sub> = 1.65 V		4		
	Lavor lavor Lavorand accommend	V <sub>CC</sub> = 2.3 V		12		
l <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		12	mA	
		V <sub>CC</sub> = 3 V		24		
Δt/Δν	Input transition rise or fall rate			10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	85	°C	

<sup>(1)</sup> All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> This value is limited to 4.6 V maximum.

<sup>(4)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.



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#### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN TYP(1) MA	X UNIT	
		I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2		
		I <sub>OH</sub> = -4 mA	1.65 V	1.2		
		I <sub>OH</sub> = -6 mA	2.3 V	2		
V <sub>OH</sub>   I <sub>OH</sub> =   I <sub>OH</sub> = -		2.3 V	1.7	V		
		I <sub>OH</sub> = -12 mA	2.7 V	2.2		
			3 V	2.4		
		I <sub>OH</sub> = -24 mA	3 V	2		
		I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V	0.	2	
		I <sub>OL</sub> = 4 mA	1.65 V	0.4	5	
.,		I <sub>OL</sub> = 6 mA	2.3 V	0.	4 V	
V <sub>OL</sub>		10	2.3 V	0.	7 V	
I <sub>I</sub>		1 <sub>OL</sub> = 12 mA	2.7 V	0.	4	
		I <sub>OL</sub> = 24 mA	3 V	0.5	5	
I <sub>I</sub>		$V_I = V_{CC}$ or GND	3.6 V	<u>+</u>	5 μΑ	
		V <sub>I</sub> = 0.57 V	1.65 V	25		
$I_{BHL}^{(2)}$		V <sub>I</sub> = 0.7 V	2.3 V	45	μΑ	
	V <sub>I</sub> = 0.8 V	3 V	75			
		V <sub>I</sub> = 1.07 V	1.65 V	-25		
I <sub>BHH</sub> (3)		V <sub>I</sub> = 1.7 V	2.3 V -45		μΑ	
	3) \	V <sub>I</sub> = 2 V	3 V	3 V -75		
			1.95 V	200		
I <sub>BHLO</sub> <sup>(4)</sup>	OL  BHL (2)  BHL (3)  BHLO (4)  BHLO (5)  DZ (6)  CC  Alcc  Control inputs  D  A ports	$V_I = 0$ to $V_{CC}$	2.7 V	300	μΑ	
			2.3 V 2.3 V 1.7 2.7 V 2.2 3 V 2.4 3 V 2.4 3 V 2 1.65 V to 3.6 V 2 1.65 V 2.3 V 2.7 V 3.6 V 2.5 2.3 V 2.7 V 35 1.65 V 25 2.3 V 45 3 V 75 1.65 V -25 2.3 V -45 3 V -75 1.95 V 200 2.7 V 300 3.6 V 500 1.95 V -200 2.7 V -300 3.6 V 500 3.6 V 500 3.6 V 3.8 V 3	500		
			1.95 V	-200		
$V_{OH} \begin{tabular}{ll} & I_{OH} = -100 \ \mu A \\ \hline & I_{OH} = -4 \ mA \\ \hline & I_{OH} = -6 \ mA \\ \hline \\ & I_{OH} = -12 \ mA \\ \hline & I_{OH} = -12 \ mA \\ \hline & I_{OH} = -12 \ mA \\ \hline & I_{OL} = 100 \ \mu A \\ \hline & I_{OL} = 4 \ mA \\ \hline & I_{OL} = 4 \ mA \\ \hline & I_{OL} = 12 \ mA \\ \hline & I_{OL} = 12 \ mA \\ \hline & I_{OL} = 24 \ mA \\ \hline & I_{OL} = 12 \ mA \\ \hline & I_{OL} = 0.57 \ V \\ \hline & V_{I} = 0.57 \ V \\ \hline & V_{I} = 0.7 \ V \\ \hline & V_{I} = 0.8 \ V \\ \hline & V_{I} = 1.07 \ V \\ \hline & V_{I} = 1.07 \ V \\ \hline & V_{I} = 1.7 \ V \\ \hline & V_{I} = 2 \ V \\ \hline & I_{BHH}(^{(3)}) \ & V_{I} = 0 \ to \ V_{CC} \\ \hline & I_{BHLO}(^{(4)}) \ & V_{I} = 0 \ to \ V_{CC} \\ \hline & I_{OZ}(^{(6)}) \ & V_{O} = V_{CC} \ or \ GND \\ \hline & I_{CC} \ & V_{I} = V_{CC} \ or \ GND, \ I_{O} = 0 \\ \hline & One \ input \ at \ V_{CC} \ or \ GND \\ \hline & C_{I} \ & Control \ inputs \\ \hline & D \ & V_{I} = V_{CC} \ or \ GND \\ \hline \end{array}$	$V_I = 0$ to $V_{CC}$	2.7 V	-300	μΑ		
			3.6 V	-500		
I <sub>OZ</sub> <sup>(6)</sup>		$V_O = V_{CC}$ or GND	3.6 V	±1	0 μΑ	
I <sub>CC</sub>		$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V	3	0 μΑ	
		One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V	75	0 μΑ	
0	Control inputs		0.01/	3		
C <sub>i</sub>	D	$v_1 = v_{CC}$ or GND	3.3 V	4	pF	
_	A ports	V V 0ND	0.01/	4.5	_	
C <sub>io</sub>		$v_0 = v_{CC}$ or GND	3.3 V	4.5	pF	
Co	Q	$V_O = V_{CC}$ or GND	3.3 V	3	pF	

 <sup>(1)</sup> All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.
 (2) The bus-hold circuit can sink at least the minimum low sustaining current at V<sub>IL</sub> max. I<sub>BHL</sub> should be measured after lowering V<sub>IN</sub> to GND and then raising it to  $V_{\text{IL}}$  max.

The bus-hold circuit can source at least the minimum high sustaining current at V<sub>IH</sub> min. I<sub>BHH</sub> should be measured after raising V<sub>IN</sub> to  $V_{\text{CC}}$  and then lowering it to  $V_{\text{IH}}$  min.

An external driver must source at least I<sub>BHLO</sub> to switch this node from low to high.

An external driver must sink at least  $I_{BHHO}$  to switch this node from high to low. For I/O ports, the parameter  $I_{OZ}$  includes the input leakage current.

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#### **TIMING REQUIREMENTS**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V ± 0.2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V	UNIT
		MIN MA	MIN MAX	MIN MAX	
t <sub>w</sub>	Pulse duration, LE high	2	2	2	ns
t <sub>su</sub>	Setup time, data before LE $\downarrow$	0.9	0.9	0.9	ns
t <sub>h</sub>	Hold time, data after LE↓	0.9	0.9	0.9	ns

#### **SWITCHING CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INPUT)	(OUTPUT)	TYP	MIN	MAX	MIN	MAX	
	D	Υ	2.2	0.5	3.2	0.5	3	
	Α	0	2.2	0.5	3.2	0.5	3	ns
t <sub>pd</sub>	LE	Q	2.8	0.5	3.3	0.5	3	
	A or B	B or A	2.2	0.5	3.2	0.5	3	
	LOE	Q	2.9	0.7	4.9	0.7	4.7	
t <sub>en</sub>	TOE	A == D	3	0.7	4.6	0.7	4.4	ns
	DIR	A or B	3.4	0.7	4.9	0.7	4.7	
	LOE	Q	2.8	0.5	4.3	0.5	4.1	
t <sub>dis</sub>	TOE	A or D	3.2	0.5	4.3	0.5	4.1	ns
	DIR	A or B	3.4	0.5	4.9	0.5	4.7	



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## OPERATING CHARACTERISTICS(1)

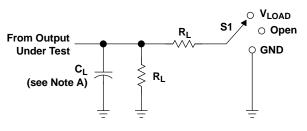
 $T_A = 25^{\circ}C$ 

PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	V <sub>CC</sub> = 3.3 V	UNIT	
	PARAMEI	EK	TEST CONDITIONS	TYP TYP TYP		UNIT	
C <sub>pd</sub> <sup>(2)</sup> (each output)		A outputs enabled, Q outputs disabled, One A output switching	$\label{eq:control_approx} \begin{split} &\text{One } f_A = 10 \text{ MHz}, \\ &\text{One } f_B = 10 \text{ MHz}, \\ &\overline{\text{TOE}} = \text{GND}, \\ &\overline{\text{LOE}} = \text{V}_{\text{CC}}, \\ &\text{DIR} = \text{GND}, \\ &C_L = 0 \text{ pF} \end{split}$	12	14	19	
	Power dissipation capacitance	B outputs enabled, Q outputs disabled, One B output switching	$\label{eq:continuous_problem} \begin{split} &\text{One } f_A = 10 \text{ MHz}, \\ &\text{One } f_B = 10 \text{ MHz}, \\ &\overline{\text{TOE}} = \text{GND}, \\ &\overline{\text{LOE}} = \text{V}_{\text{CC}}, \\ &\text{DIR} = \text{GND}, \\ &C_L = 0 \text{ pF} \end{split}$	12	14	21	pF
		Q outputs enabled, A and B I/Os isolated, One Q output switching	$\label{eq:controller} \begin{split} &\text{One } f_A = 10 \text{ MHz}, \\ &\text{One } f_{LE} = 20 \text{ MHz}, \\ &\text{One } f_Q = 10 \text{ MHz}, \\ &\overline{\text{TOE}} = V_{CC}, \\ &\overline{\text{LOE}} = \text{GND}, \\ &C_L = 0 \text{ pF} \end{split}$	11	13	19	·
		One Y output switching, A and B I/Os isolated, Q outputs disabled	$\label{eq:constraints} \begin{split} &\text{One f}_D = 10 \text{ MHz},\\ &\text{One f}_Y = 10 \text{ MHz},\\ &\overline{\text{TOE}} = V_{CC},\\ &\overline{\text{LOE}} = V_{CC},\\ &C_L = 0 \text{ pF} \end{split}$	7	8	12	
C <sub>pd (Z)</sub>	Power dissipation capacitance	A and B I/Os isolated, Q outputs disabled, One LE and one A data input switching	$\label{eq:continuous_section} \begin{split} &\text{One } f_A = 10 \text{ MHz}, \\ &\text{One } f_{LE} = 20 \text{ MHz}, \\ &f_{\underline{O}} \text{ not switching}, \\ &\overline{\text{TOE}} = V_{CC}, \\ &\overline{\text{LOE}} = V_{CC}, \\ &C_L = 0 \text{ pF} \end{split}$	4	5	11	pF
C <sub>pd</sub> <sup>(3)</sup> (each LE)	Power dissipation capacitance	A and B I/Os isolated, Q outputs disabled, One LE input switching	$\begin{aligned} &f_A \text{ not switching,} \\ &\text{One } f_{LE} = 20 \text{ MHz,} \\ &f_C \text{ not switching,} \\ &\overline{\text{TOE}} = V_{CC}, \\ &\overline{\text{LOE}} = V_{CC}, \\ &C_L = 0 \text{ pF} \end{aligned}$	6	7	9	pF

 <sup>(1)</sup> Total device C<sub>pd</sub> for multiple (m) outputs switching and (n) LE inputs switching = [m \* C<sub>pd</sub> (each output)] + [n \* C<sub>pd</sub> (each LE)].
 (2) C<sub>pd</sub> (each output) is the C<sub>pd</sub> for each data bit (input and output circuitry) when it operates at 10 MHz (Note: the LE is operating at 20 MHz in this test, but its I<sub>CC</sub> component has been subtracted).
 (3) C<sub>pd</sub> (each LE) is the C<sub>pd</sub> for the clock circuitry only when it operates at 20 MHz.



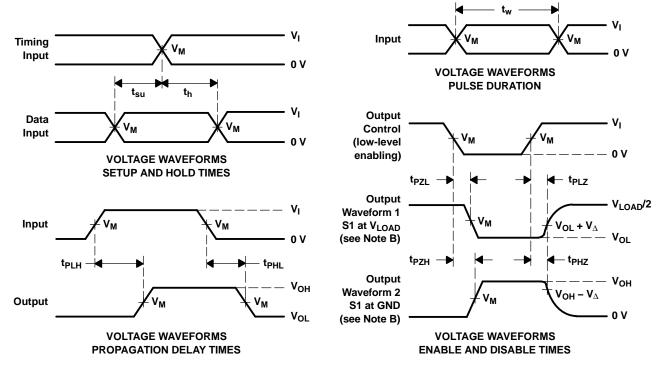
#### PARAMETER MEASUREMENT INFORMATION



TEST	<b>S</b> 1
t <sub>pd</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

LOAD CIRCUIT

V	INPUT		V	v	(	6	v
V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	C <sub>L</sub>	$R_L$	$V_{\!\scriptscriptstyle \Delta}$
1.8 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_{O} = 50 \Omega$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.

Figure 1. Load Circuit and Voltage Waveforms







#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74ALVCH16973DGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16973DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16973DGVRE4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16973DGVRG4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16973DLG4	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCH16973DLRG4	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16973DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16973DGVR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16973DL	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCH16973DLR	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVCH16973DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1
SN74ALVCH16973DGVR	TVSOP	DGV	48	2000	330.0	24.4	6.8	10.1	1.6	12.0	24.0	Q1
SN74ALVCH16973DLR	SSOP	DL	48	1000	330.0	32.4	11.35	16.2	3.1	16.0	32.0	Q1





\*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALVCH16973DGGR	TSSOP	DGG	48	2000	346.0	346.0	41.0
SN74ALVCH16973DGVR	TVSOP	DGV	48	2000	346.0	346.0	41.0
SN74ALVCH16973DLR	SSOP	DL	48	1000	346.0	346.0	49.0

### DGG (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

#### DL (R-PDSO-G\*\*)

#### **48 PINS SHOWN**

#### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

### DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

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